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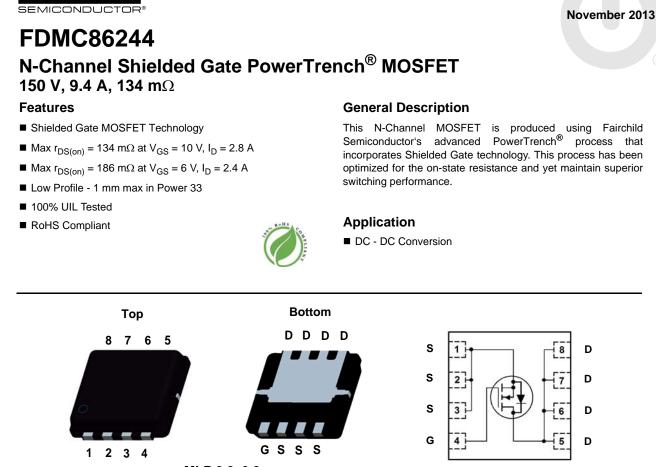


ON Semiconductor®

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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

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MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Param	eter		Ratings	Units	
V _{DS}	Drain to Source Voltage			150	V	
V _{GS}	Gate to Source Voltage			±20	V	
I _D	Drain Current -Continuous	$T_{C} = 25^{\circ}C$		9.4		
	-Continuous	T _A = 25°C	(Note 1a)	2.8	Α	
	-Pulsed	12	7			
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	12	mJ	
D	Power Dissipation	T _C = 25°C		26	14/	
P _D	Power Dissipation	T _A = 25°C	(Note 1a)	2.3	W	
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to + 150	°C	

Thermal Characteristics

FAIRCHILD

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	4.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note	1a) 125	C/vv

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86244	FDMC86244	Power 33	13"	12 mm	3000 units

FDMC86244 N-Channel Shielded Gate PowerTrench $^{ extsf{m}}$ MOSFET

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_{D} = 250 \ \mu A, V_{GS} = 0 \ V$	150			V
$\Delta BV_{DSS} = \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		106		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Chara	acteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	2	2.6	4	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		-9		mV/°C
		V _{GS} = 10 V, I _D = 2.8 A		105	134	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 6 V, I_D = 2.4 A$		120	186	mΩ
		V _{GS} = 10 V, I _D = 2.8 A, T _J = 125 °C		199	254	
9 _{FS}	Forward Transconductance	V _{DD} = 10 V, I _D = 2.8 A		8		S
	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V,		257	345	pF
C _{oss}	Output Capacitance	$v_{DS} = 75 v, v_{GS} = 0 v,$ 		32	45	pF
C _{rss}	Reverse Transfer Capacitance			1.8	5	pF
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			5.3	11	ns
t _r	Rise Time	V _{DD} = 75 V, I _D = 2.8 A,		1.5	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		9.9	20	ns
t _f	Fall Time			2.3	10	ns
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		4.2	5.9	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V}$ $V_{DD} = 75 \text{ V},$ $I_D = 2.8 \text{ A}$		2.4	3.4	
Q _{gs}	Total Gate Charge	$I_{\rm D} = 2.8 \rm A$		1.1		nC
Q _{gd}	Gate to Drain "Miller" Charge			1.0		nC
Drain-So	urce Diode Characteristics					
		$V_{GS} = 0 V, I_S = 2.8 A$ (Note 2)		0.81	1.3	
V _{SD}	Source to Drain Diode Forward Voltage					- V

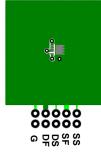
N	0	TΕ	ES

t_{rr}

Q_{rr}

1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

 $I_F = 2.8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$

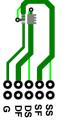


3. Starting T_J = 25 °C; N-ch: L = 1.0 mH, I_{AS} = 5.0 A, V_{DD} = 135 V, V_{GS} = 10 V.

Reverse Recovery Time

Reverse Recovery Charge

a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

48

38

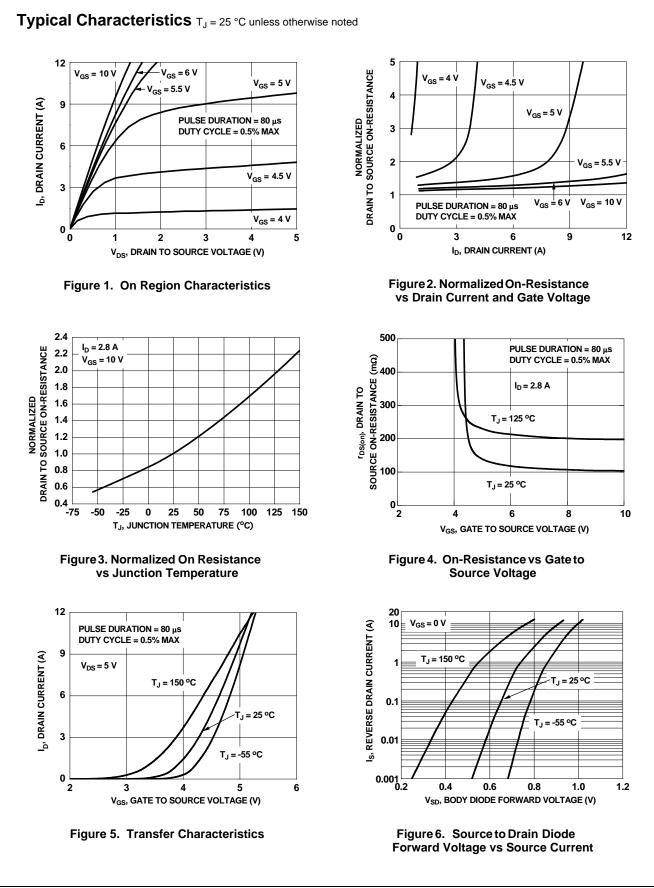
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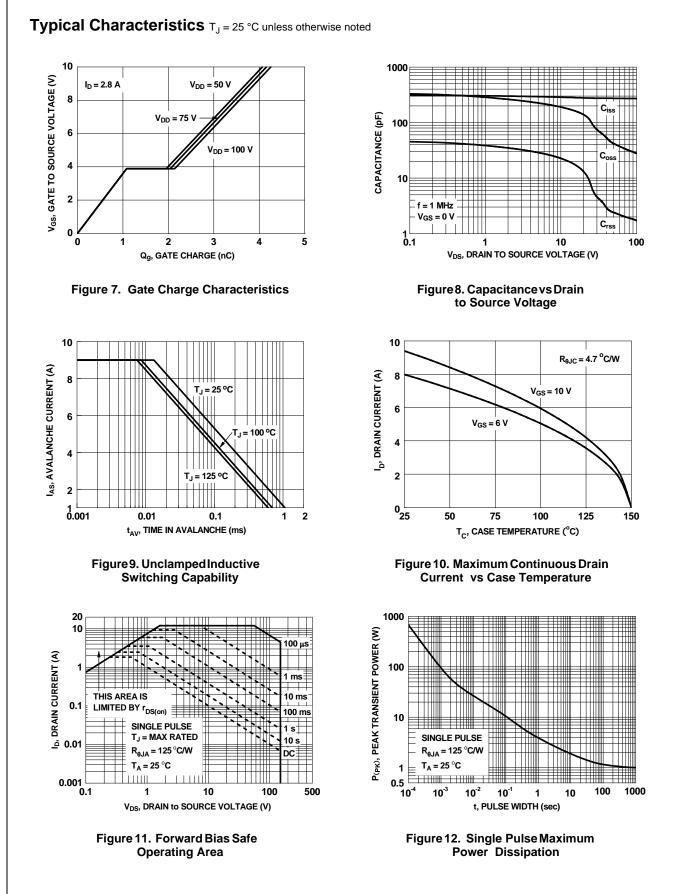
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ns

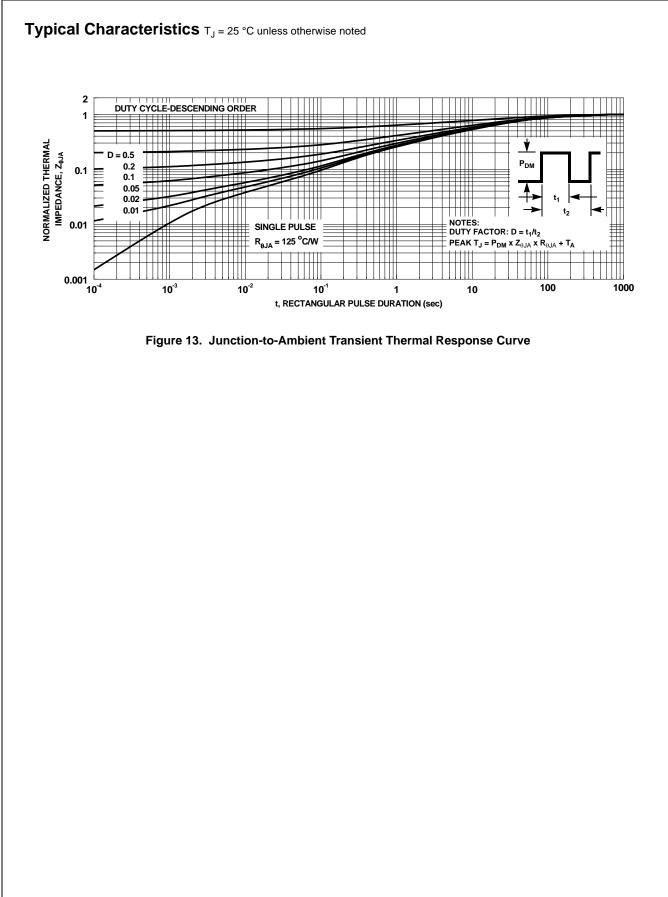
nC

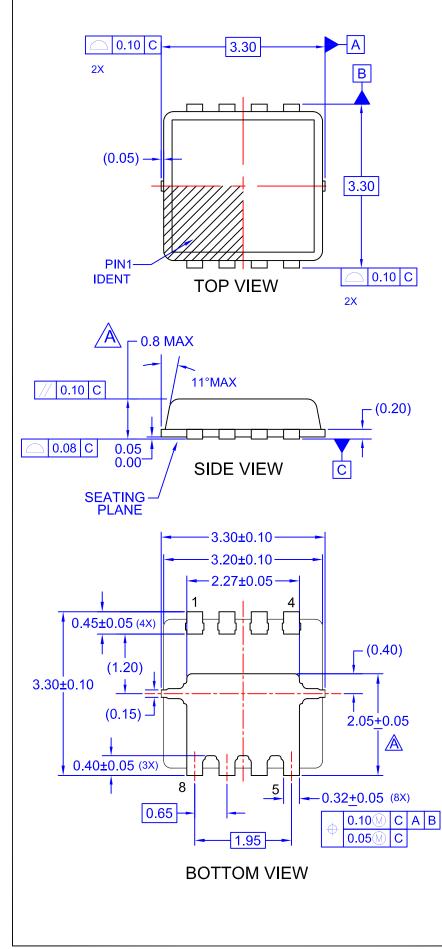
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

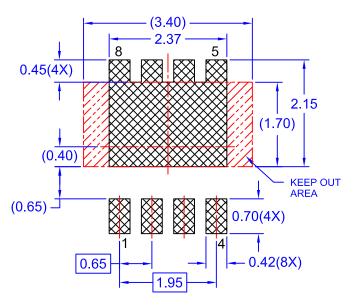




FDMC86244 N-Channel Shielded Gate PowerTrench[®] MOSFET







RECOMMENDED LAND PATTERN

NOTES:

- A EXCEPT AS NOTED, PACKAGE CONFORMS TO JEDEC REGISTRATION MO-240 VARIATION BA.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- E. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.
- F. FLANGE DIMENSIONS INCLUDE INTERTERMINAL FLASH OR PROTRUSION. INTERTERMINAL FLASH OR PROTRUSION SHALL NOT EXCEED 0.25MM PER SIDE.
- G. IT IS RECOMMENDED TO HAVE NO TRACES OR VIA WITHIN THE KEEP OUT AREA.
- H. DRAWING FILENAME: MKT-MLP08Trev4.
- I. GENERAL RADII FOR ALL CORNERS SHALL BE 0.20MM MAX.



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